



<b>Search Notes</b>  	Application/Control No.  10010915	Applicant(s)/Patent Under Reexamination  PILLAI ET AL.
	Examiner Gerezgiher, Yemane M	Art Unit 2144

Notes	Date	Examiner
Updated East Text Search (US-PGPUB; USPAT; EPO; JPO; DERWENT)	10/19/2006	YMG
NPL search (CiteSeer + Google API proximity search)	10/19/2006	YMG
Claim directed Interference Search US-PGPUB DB	10/19/2006	YMG
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<b>Interference Searched</b>  	Application/Control No.  10010915	Applicant(s)/Patent Under Reexamination  PILLAI ET AL.
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Class	SubClass	Date	Examiner
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	<p>Examiner</p> <p>Gerezgiher, Yemane M</p>	<p>Art Unit</p> <p>2144</p>

Class	SubClass	Date	Examiner
709	223	10/19/2006	YMG
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